

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/803,961	NAGASHII ET AL.
	<b>Examiner</b> Marc A. Scharich	<b>Art Unit</b> 3611

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
See Attached		4/23/2007	MAS